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(54) Title (EN): TEST TUBE CAPPING AND DE-CAPPING APPARATUS

(54) Title (FR): APPAREIL D'ENCAPSULATION ET DE DÉSENCAPSULATION DE TUBES À ESSAI

(57) Abstract:

(EN): An apparatus (100) for automated capping and de-capping of test tubes (112) having an ejector pin (230) system for individualized cap (113) ejection.

(FR): L'invention porte sur un appareil pour l'encapsulation et la désencapsulation automatiques de tubes à essai, lequel appareil a un système de broche d'éjecteur pour une éjection de capsule individualisée.

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